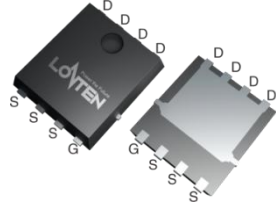
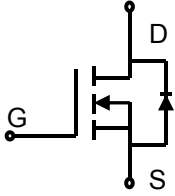



Lonten N-channel 100V, 107A, 4.35mΩ Power MOSFET

<p>Description These N-Channel enhancement mode power field effect transistors are using shielded gate trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.</p> <p>Features</p> <ul style="list-style-type: none"> ◆ 100V, 107A, $R_{DS(on),max}=4.35m\Omega@V_{GS} = 10V$ ◆ Improved dv/dt capability ◆ Fast switching ◆ 100% EAS Guaranteed ◆ Green device available <p>Applications</p> <ul style="list-style-type: none"> ◆ Motor Drives ◆ UPS ◆ DC-DC Converter 	<p>Product Summary</p> <table> <tr> <td>V_{DSS}</td> <td>100V</td> </tr> <tr> <td>$R_{DS(on),max}@V_{GS}=10V$</td> <td>4.35mΩ</td> </tr> <tr> <td>I_D</td> <td>107A</td> </tr> </table> <p>Pin Configuration</p>  <p style="text-align: center;">DFN5×6</p>  <p style="text-align: center;">N-Channel MOSFET</p> 	V_{DSS}	100V	$R_{DS(on),max}@V_{GS}=10V$	4.35mΩ	I_D	107A
V_{DSS}	100V						
$R_{DS(on),max}@V_{GS}=10V$	4.35mΩ						
I_D	107A						

Absolute Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	100	V
Continuous drain current ($T_C = 25^\circ C$) ($T_C = 100^\circ C$)	I_D	107 67	A A
Pulsed drain current ¹⁾	I_{DM}	428	A
Gate-Source voltage	V_{GSS}	± 20	V
Avalanche energy ²⁾	E_{AS}	272	mJ
Power Dissipation	P_D	83	W
Storage Temperature Range	T_{STG}	-55 to +150	$^\circ C$
Operating Junction Temperature Range	T_J	-55 to +150	$^\circ C$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.5	$^\circ C/W$
Thermal Resistance, Junction-to-Ambient ³⁾	$R_{\theta JA}$	65	$^\circ C/W$

Package Marking and Ordering Information

Device	Device Package	Marking	Units/Reel
LSGN10R042	DFN 5×6	LSGN10R042	5000

Electrical Characteristics

T_J = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _D =250uA	100	---	---	V
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	2.0	---	4.0	V
Drain-source leakage current	I _{DSS}	V _{DS} =100 V, V _{GS} =0 V, T _J = 25°C	---	---	1	μA
		V _{DS} =100V, V _{GS} =0 V, T _J = 150°C	---	---	100	μA
Gate leakage current, Forward	I _{GSSF}	V _{GS} =20 V, V _{DS} =0 V	---	---	100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-20V, V _{DS} =0 V	---	---	-100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =40 A, T _J = 25°C	---	3.95	4.35	mΩ
		T _J = 150°C	---	8.7	---	
Forward transconductance	g _{fs}	V _{DS} =20V , I _D =40A	---	120	---	S
Dynamic characteristics						
Input capacitance	C _{iss}	V _{DS} = 50V, V _{GS} = 0 V, f = 250kHz	---	3838	---	pF
Output capacitance	C _{oss}		---	1252	---	
Reverse transfer capacitance	C _{riss}		---	13.4	---	
Turn-on delay time	t _{d(on)}	V _{DD} = 40V, V _{GS} =15V, I _D =60 A	---	29.4	---	ns
Rise time	t _r		---	29.2	---	
Turn-off delay time	t _{d(off)}		---	80.2	---	
Fall time	t _f		---	30.8	---	
Gate resistance	R _g	V _{GS} =0V, V _{DS} =0V, f=1MHz	---	2.0	---	Ω
Gate charge characteristics						
Gate to source charge	Q _{gs}	V _{DS} =80 V, I _D =80A, V _{GS} = 10 V	---	20.5	---	nC
Gate to drain charge	Q _{gd}		---	16	---	
Gate charge total	Q _g		---	65	---	
Gate plateau voltage	V _{plateau}		---	5.5	---	V
Output Charge	Q _{oss}	V _{DS} =80 V, V _{GS} = 0V	---	138	---	nC
Drain-Source diode characteristics and Maximum Ratings						
Continuous Source Current	I _S		---	---	59	A
Pulsed Source Current	I _{SM}		---	---	236	A
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =80A, T _J =25°C	---	---	1.4	V
Reverse Recovery Time	t _{rr}	I _S =80A, di/dt=100A/us, T _J =25°C	---	55.6	---	ns
Reverse Recovery Charge	Q _{rr}		---	233	---	nC

Notes:

- 1: Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2: V_{DD}=50V, V_{GS}=10V, L=0.5mH, I_{AS}=33A, R_G=25Ω, Starting T_J=25°C.
- 3: Weld the device to a PCB board with the size of 32mm*36mm and then place it in an one-cubic-foot air static box.

Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

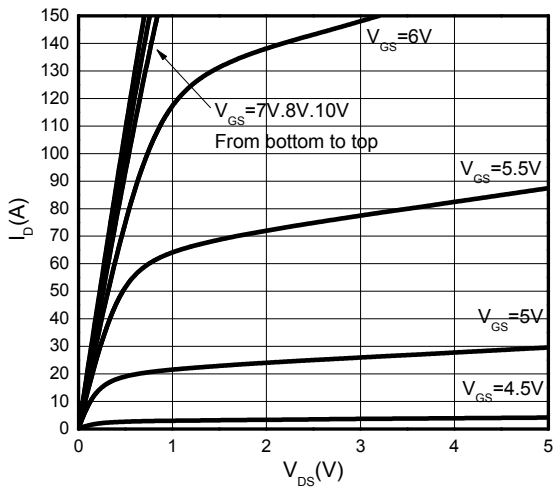


Figure 2. Transfer Characteristics

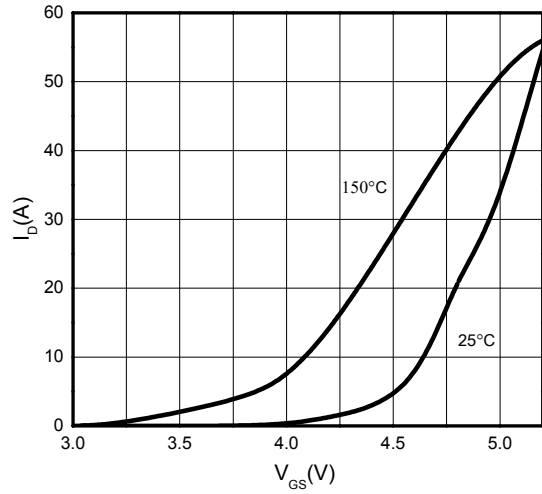


Figure 3. On-Resistance vs. Drain Current

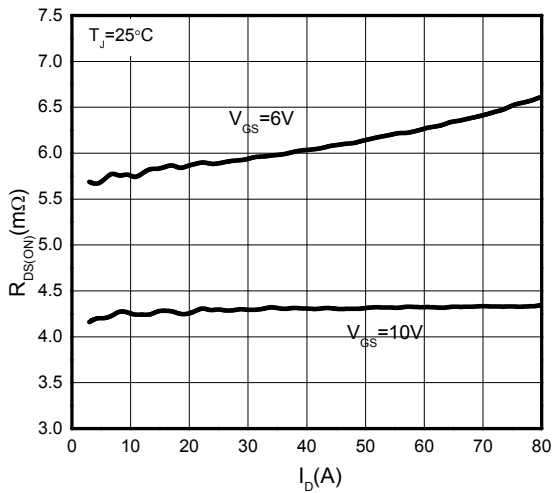


Figure 4. On-Resistance vs. Temperature

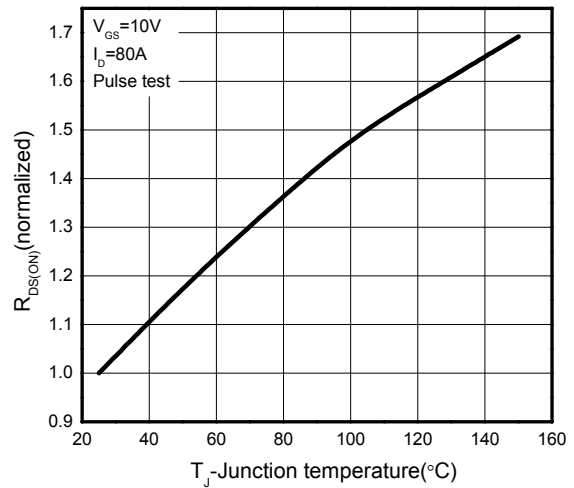


Figure 5. Breakdown Voltage vs. Temperature

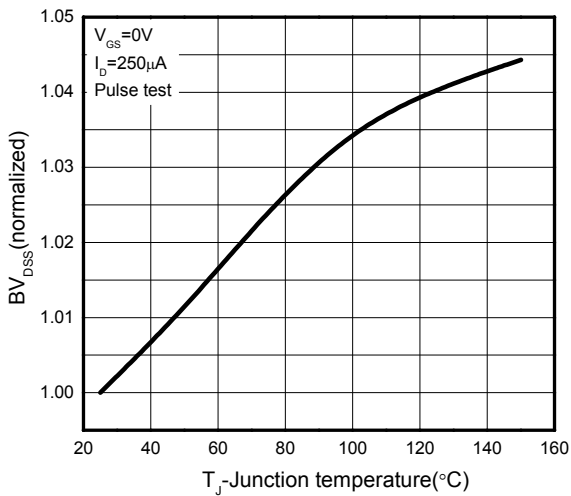


Figure 6. Threshold Voltage vs. Temperature

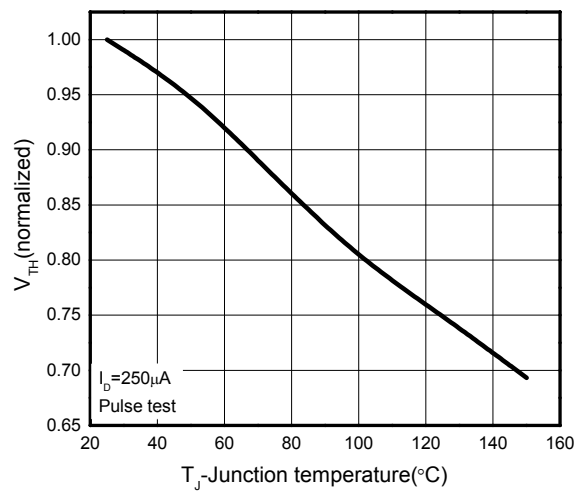


Figure 7. Rds(on) vs. Gate Voltage

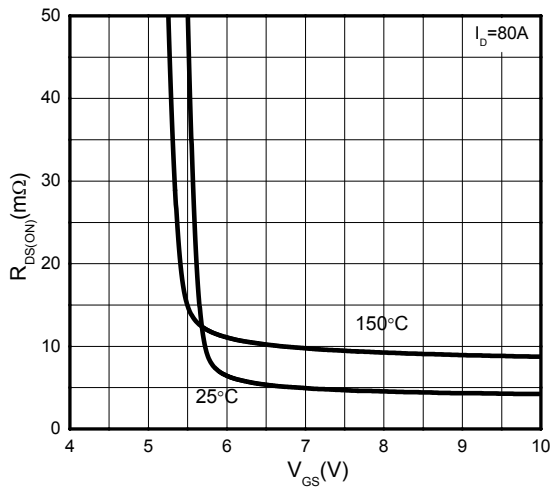


Figure 8. Body-Diode Characteristics

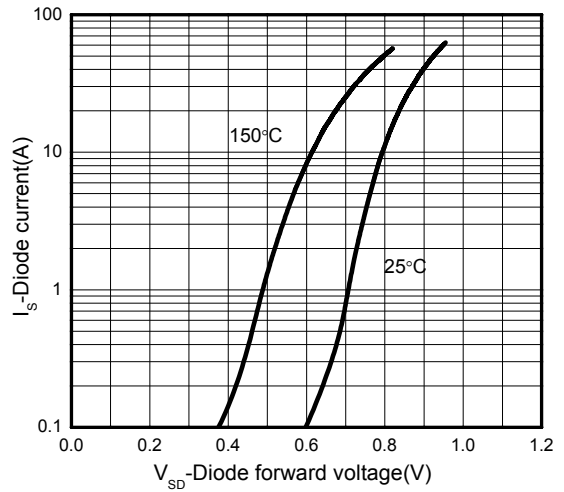


Figure 9. Capacitance Characteristics

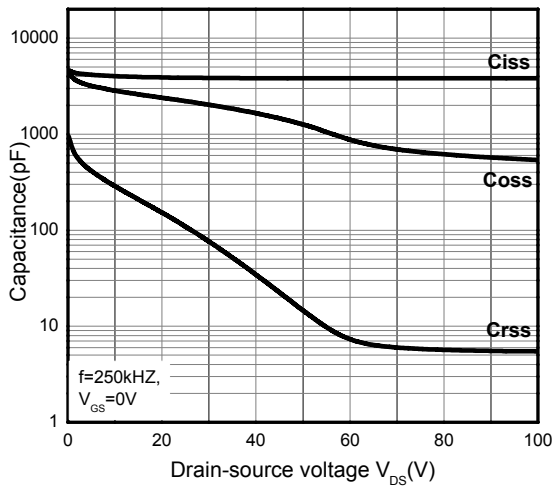


Figure 10. Gate Charge Characteristics

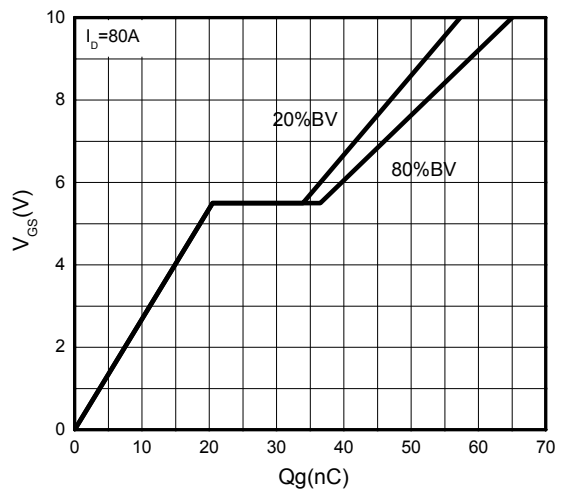


Figure 11. Drain Current Derating

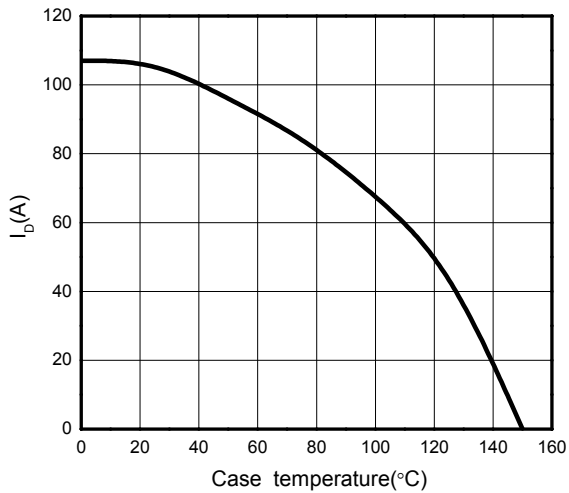


Figure 12. Power Dissipation vs. Temperature

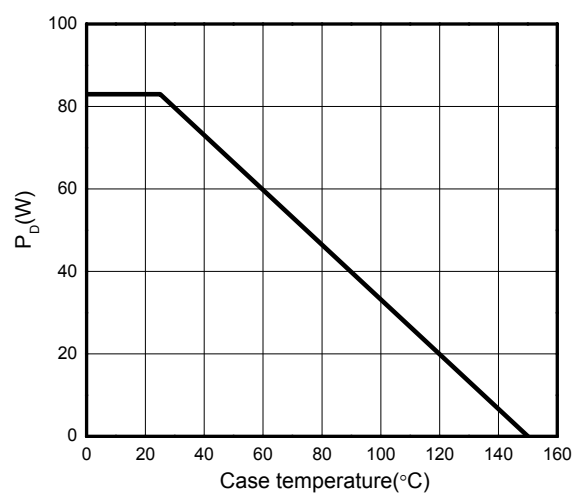


Figure 13: Safe Operating Area

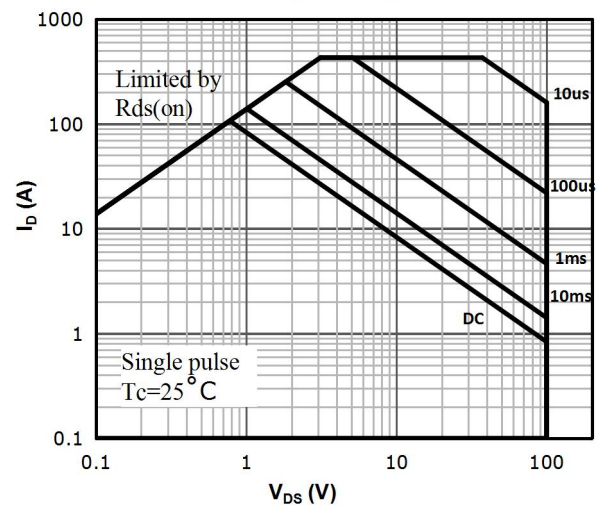
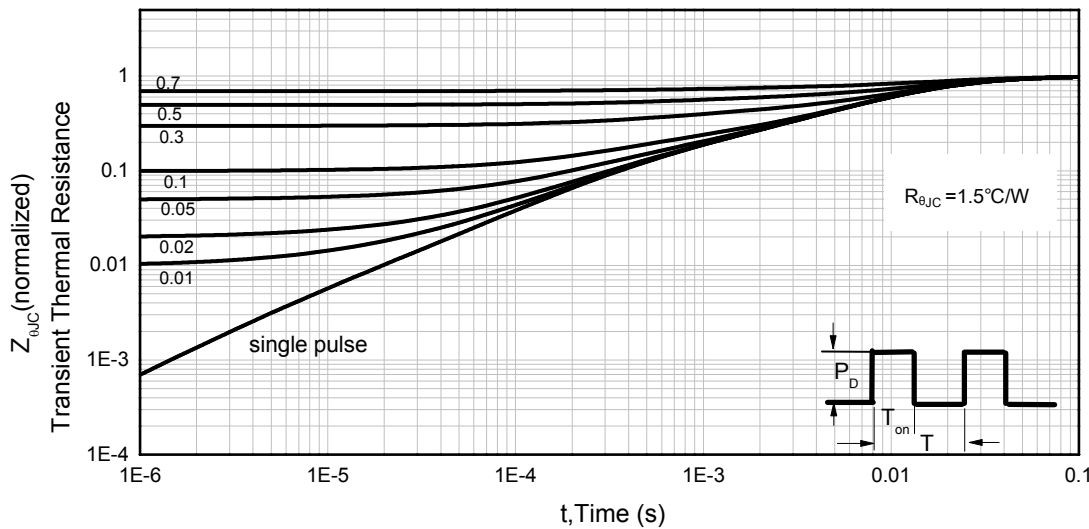
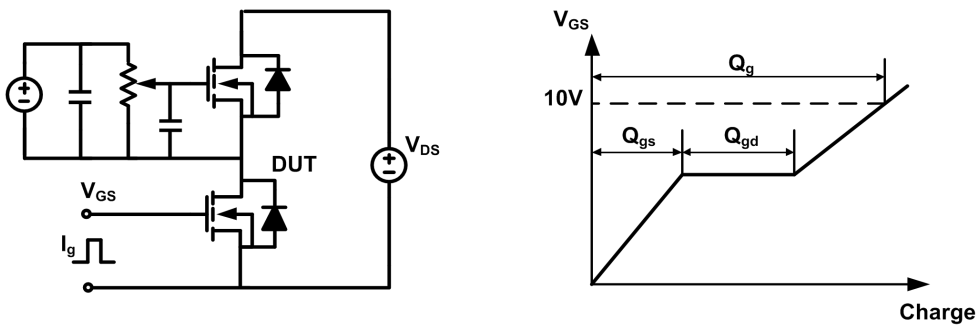


Figure 14. Normalized Maximum Transient Thermal Impedance (R_{thJC})

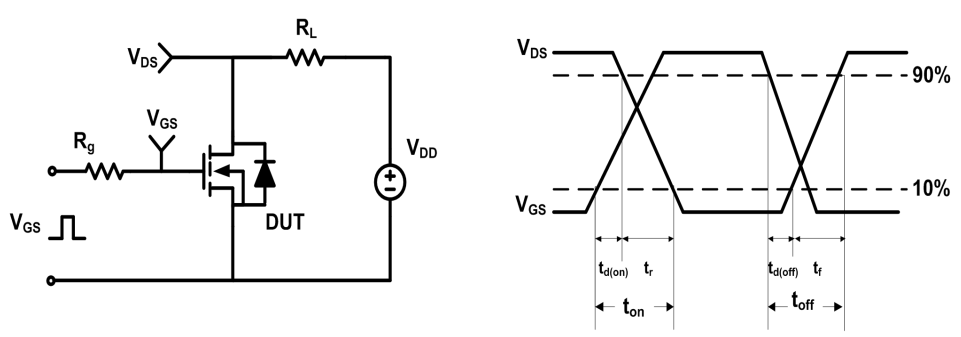


Test Circuit & Waveforms

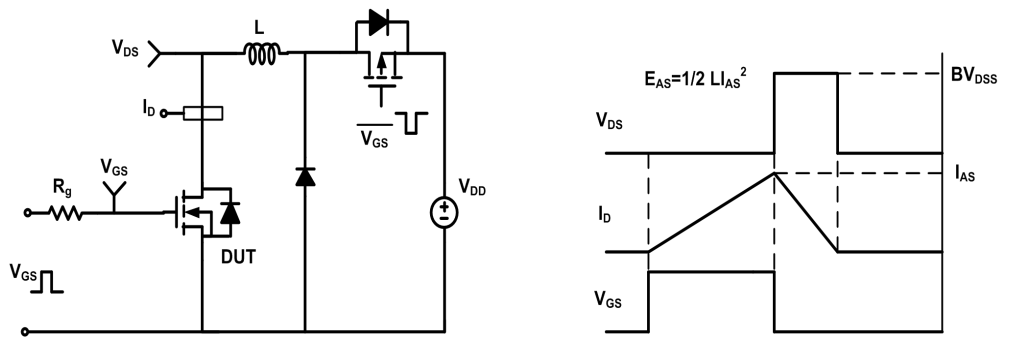
Gate Charge Test Circuit & Waveform



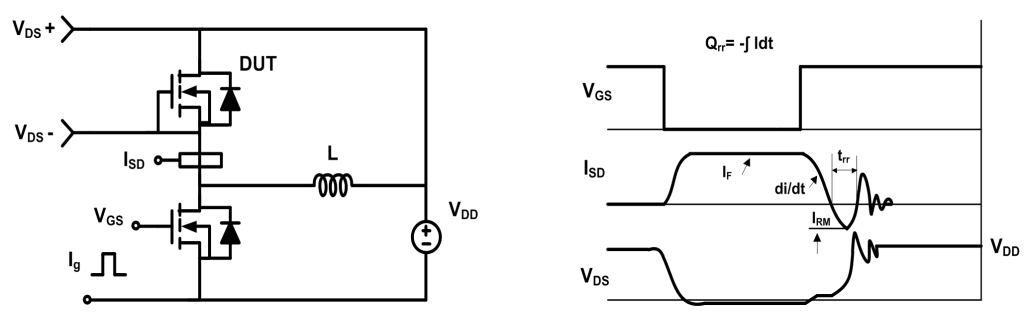
Resistive Switching Test Circuit & Waveform



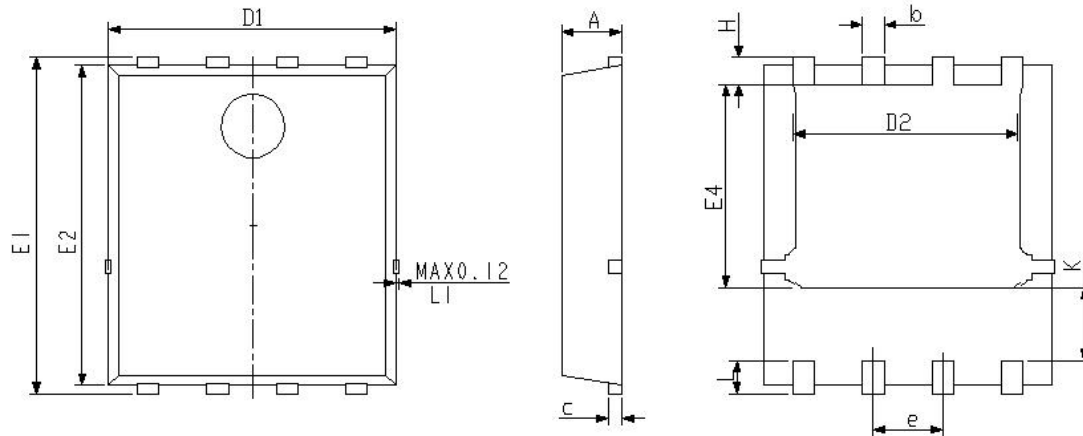
Unclamped Inductive Switching (UIS) Test Circuit & Waveform



Diode Recovery Test Circuit & Waveform



Mechanical Dimensions for DFN 5×6



DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES	
SYMBOL	MIN	MAX	MIN	MAX
A	0.85	1.20	0.033	0.047
b	0.30	0.51	0.012	0.020
c	0.15	0.35	0.006	0.014
D1	4.80	5.40	0.189	0.213
D2	3.70	4.55	0.146	0.179
E1	5.95	6.35	0.234	0.250
E2	5.45	6.06	0.215	0.239
E4	3.30	3.92	0.130	0.154
e	1.27BSC		0.05BSC	
L	0.3	0.71	0.012	0.028
H	0.38	0.71	0.015	0.028
K	1.15	1.45	0.045	0.057